Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10585636	AEBI, PAUL
Examiner	Art Unit
BINH K TIEU	2614

SEARCHED					
Class	Subclass	Date	Examiner		
379	114.01, 114.14, 114.16, 114.17, 114.2, 121.01, 130, 144.01, 144.04, 144.06	06/20/2008	BKT		
455	405, 406, 407, 408, 411, 558	06/20/2008	BKT		
713	162, 164, 168, 171	06/20/2008	BKT		

SEARCH NOTES			
Search Notes	Date	Examiner	
WEST DATABASES SEARCHES	06/19/2008	BKT	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
379	114.16, 114.2	06/20/2008	BKT	
455	407, 408	06/20/2008	BKT	
713	168, 171	06/20/2008	BKT	

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